

FINAL PRODUCT/PROCESS CHANGE NOTIFICATION # 16761

Generic Copy

Issue Date: 10-Nov-2011

TITLE: EPI process service at IQE (Cardiff, UK) as buffer capacity, supporting production volume ramp-up required to meet increased demand.

INITIAL SHIP DATE: N/A

AFFECTED CHANGE CATEGORY(S): Wafer fab (capacity increase)

FOR ANY QUESTIONS CONCERNING THIS NOTIFICATION:

Contact your local ON Semiconductor Sales Office or Veronique Hooft Veronique.Hooft@onsemi.com>

SAMPLES: N/A: EPI equipment and process are identical.

ADDITIONAL QUALIFICATION DATA: Available

Contact your local ON Semiconductor Sales Office or Veronique Hooft <p

NOTIFICATION TYPE:

Final Product/Process Change Notification (FPCN)

DESCRIPTION AND PURPOSE:

This Final PCN relates to EPI process service for I2T process at IQE, (Cardiff, UK).

This EPI process service has identical EPI equipment, enabling exactly same EPI process. EPI service is enabling additional EPI process buffer capacity until additional EPI equipment are installed and qualified in Oudenaarde facility. EPI service will only be used as flexible capacity buffer for I2T process.

Process change was initially planned for limited period. However due to the continued high market demand the use of this EPI buffer capacity has to extend in time and will be continued to be used as buffer when required.

RELIABILITY DATA SUMMARY: N/A (no reliability impact)

ELECTRICAL CHARACTERISTIC SUMMARY: N/A (Electrical Performance will continue to meet specifications)

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List of affected Customer Specific Parts:

| Conti Part Number | ONSEMI Sellable Code | Internal Product | | | |
|-------------------|----------------------|------------------|--|--|--|
| A2C00410100 | NCV70522MN003R2G | 0C522 | | | |
| A2C00034727 | AMIS30660CANH2RG | 0CANH | | | |
| A2C00033926 | AMIS41682CANM1RG | 0CANM | | | |
| A2C00046753 | AMIS41683CANN1RG | 0CANN | | | |
| A2C40002735 | 0HSBA-004-XDS | OHSBA | | | |
| A2C00035237 | AMIS30600LINI1RG | OLINI | | | |
| A2C00008332 | 0MAFA-001-XDF | 0MAFA | | | |
| A2C00038530 | OSCIA-004-XDF | OSCIA | | | |
| A2C00053712 | OSHIA-002-XTP | 0SHIA | | | |
| A2C00051037 | OSOCA-001-XTP | 0SOCA | | | |
| A2C00039697 | AMIS42665TJAA1RG | 0TJAA | | | |

Background information;

- **Goal of change:** Qualification of IQE as service for EPI deposition process, in order to support increased market demand.
- What is changed: Qualification of EPI deposition for I2T process at IQE:
 - EPI deposition equipment is identical to EPI equipment (ASM Single Wafer Reactor) at Oudenaarde site. This enables to use exactly same process in order to achieve same process characteristics.
- Implementation of change: IQE service will be used to buffer required EPI process capacity, in order to support business demand.
- Qualification plan: qualification has been successfully completed, including following topics:
 - o Metrology matching: OK
 - o EPI equipment matching: OK
 - EPI process installation (standard ON Semi process): process characteristic matching: OK
 - o Electrical matching (Etest and sort): OK
 - o PPAP documentation: OK
 - VDA audit: OK

Control plan is identical to EPI process at Oudenaarde waferFAB: see extract control plan below, showing EPI process control + additional ship instructions + extra inspection and cleaning.

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| | | | Prototype Pre-launch | | | X Producti | uction Key contact/Phone (if Req'd.) | | | | | Date (orig) | | |
|------|----------------|--|---------------------------------------|--------------------|------------------------------|-----------------|---|--------------------------------|--------|-------------|---------------------------------------|---------------------------------------|---------------|-----------|
| | | (Responsibility Code A, C, E) (Industrialization, Limite | | | ed Transfer) | (Full Transfer) | | | | | | | | |
| | | | | | | | | | | | | 25/08/200 |)8 | |
| | | Customer Part number | | | | | Core Team Technology TEP Core Team Supplier/Plant Approval/Date | | | | | Customer Engineering Approval/Date(ii | | |
| | | Part name/Description 0****-**** (****-***-C07 -***-****) | | | | | | | | | Customer Quality Approval/Date(if Rec | | | |
| | | | | | | | | | | | | | | |
| | | | | | Technology TEP Approval Date | | | | | | | | | |
| | | Supplier/Plant | | | Supplier Code | | Other Approval/Date (if Req'd.) | | | | Customer/Plant | | | |
| | | On Semiconductor/Oudenaarde | | | | NA | | | | | | | | |
| | | Part/ | Process name/ Process Characteristics | | Characteristics | Special | al | | | | Methods | | | |
| | | Process | Operation | Equipment | Spec. | Product / | Char. | Process N | | Measurement | Sample | | | |
| Inc | cluded in | | | | | | | | | | | | | |
| | TREAM flow for | | | | | | | | | | | | | |
| exte | ernal EPI | number | Description | | No. | Process | Class. | Specification/Target Equipment | | Equipment | Size | Freq. | Control Metho | |
| | | | | | | | | LSL | T | USL | | | | |
| | | 4919 | SPIN_ETS | SEZ | FS_4919 | | | | | | | | | |
| | | 7659 | RCA_CLEAN | WETLIJN | FS_7659 | | | | | | | | | |
| 2928 | INSP_EPI | | | SURFSCAN | FS_2907 | DEFDENS5/1 | | ED | C -SQC | list | KLA/TENCOR | 5#/1PL | Per lot/rur | SPC CHART |
| 8902 | PACK_SHIP | | | | | | | | | | | | | |
| | | 7702 | EPI_B2H6 | 4PP,BIORAD,EPI | FS_7702 | DIKTE MEAN | * | ED | C -SQC | list | THICKN MEAS | 1# | Per lot/rur | SPC CHART |
| | | | | | | DIKTE RANGE | | EDC -SQC list THICKN ME | | THICKN MEAS | 1# | Per lot/rur | SPC CHART | |
| | | | | | | DIKTE1/9 | | EDC -SQC list THICKN I | | THICKN MEAS | 1#/9PL | Per lot/rur | SPC CHART | |
| | | | | | | RSH MEAN | | EDC -SQC list 4 | | 4 POINT PRO | 1 | Per lot/rur | SPC CHART | |
| | | | | | | RSH RANGE | | EDC -SQC list | | 4 POINT PRO | 1 | Per lot/rur | SPC CHART | |
| | | | | | | RSH1/9 | | EDC -SQC list | | 4 POINT PRO | 1#/9PL | Per lot/rur | SPC CHART | |
| 8903 | UNPACK_REC | | | | | | | | | | | | | |
| 3343 | SPRAY | | | SOLVENTCLEAN | FS_3303 | | | | | | | | | |
| 2929 | INSP_EPI | | | SURFSCAN | FS_2907 | DEFDENS5/1 | | ED | C -SQC | list | KLA/TENCOR | 5#/1PL | Per lot/rur | SPC CHART |
| | <u>-</u> | 7611 | RCA_CLEAN | WETLIJN | FS_7611 | | | | | | | | | |
| | | 7001 | INIT_OX | ELLIPSOMETER,OXIDA | FS_7001 | DIKTEP1/2 | | ED | C -SQC | list | THICKN MEAS | 1#/2PL | Per lot/rur | SPC CHART |

Extract control plan, showing EPI process control + additional ship instructions + extra inspection and cleaning.

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